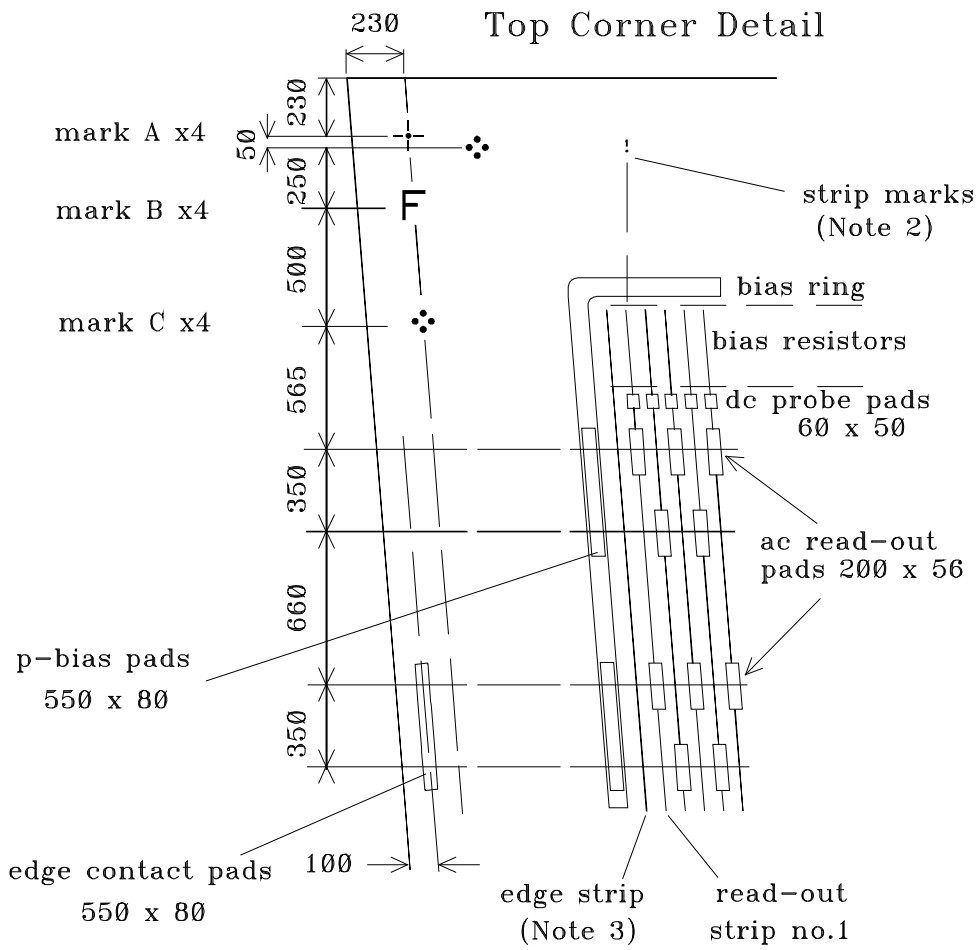
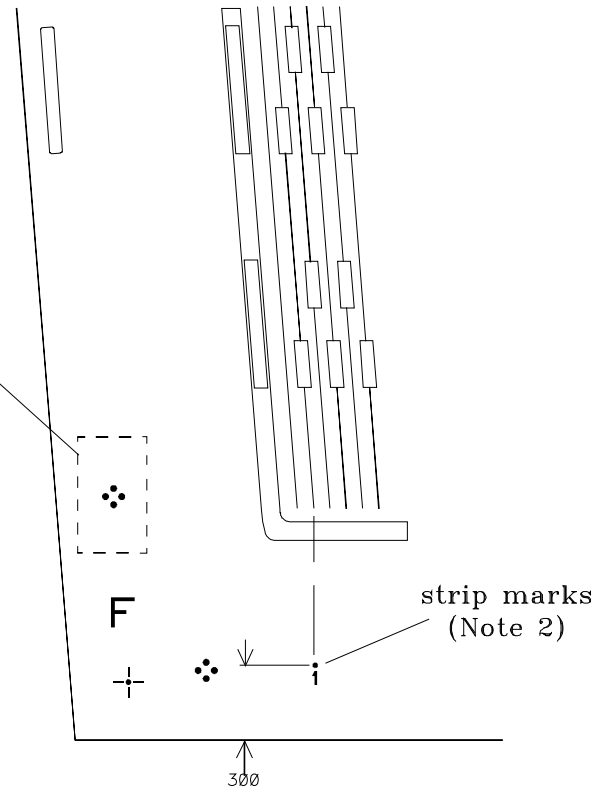
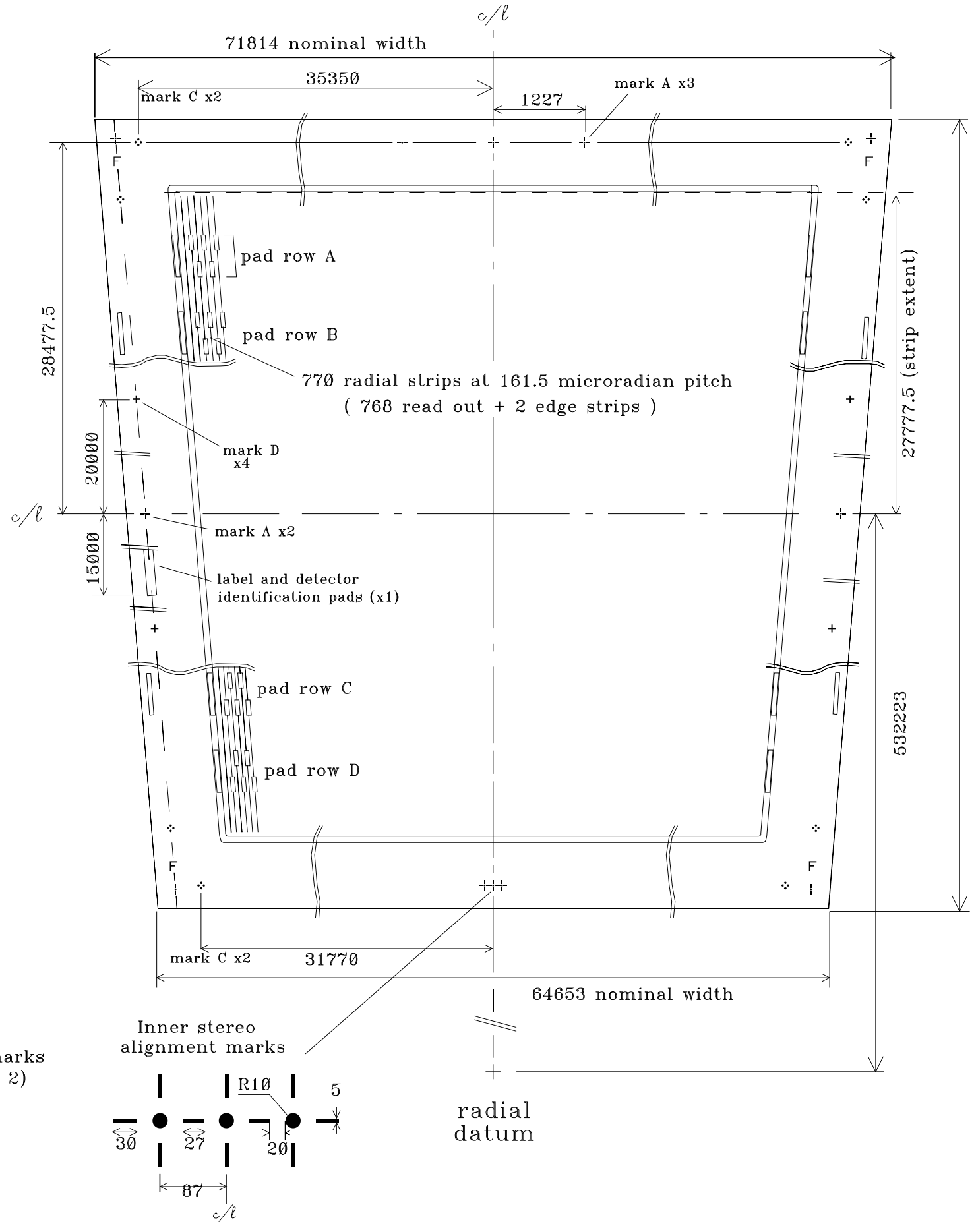
Top Corner Detail



Bottom Corner Detail





NOTES:

1. Marks, label and scratch pads detailed in drg: "ATLAS SCT Alignment/ID marks"
2. Omit individual strip marks in cases of conflict with alignment marks
3. Edge strips may be identical to strips 1–768. Alternatively, implant and metal may be d.c. connected to bias ring (omitting read-out pads) and p-bias pad optionally located between strip and bias ring.

Title	Version	Date	Drawn by (Cadence)	Checked by	Dimensions	Tolerances	Scale
ATLAS SCT W32	003	20 DEC.2000	G.A.Beck, QMW	T.J.	μm	Lithographic: +– 3μm Sawn: +–25μm	NOT TO SCALE